

Summary Statistics for TA_LH02_130814: Micro-CT Data Acquired at LLNL, Specimen 1 of 3

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Executive Summary

TA_LH02_130814				
Measured Density: 0.085 g/cm ³		X-ray tube voltages (source filter materials)		
Parameter		μ_L 100 kV(Al), Al-BHC	μ_L 100 kV(Al), H ₂ O-BHC	μ_H 160 kV (AlCu)
LAC	Mean Measured LAC (LMHU) ¹	1319	1306	888
	Standard Deviation/Mean	32%	28%	26%
	Entropy	7.46	7.33	6.86
^L Z _{eff}	From the mean measured LACs	7.96		
^{LW} Z _{eff}	From the mean measured LACs	7.29		
μ_L/μ_H	Using Al-BHC	1.49		
μ_L/μ_H	Using H ₂ O-BHC	1.47		
QA	From Cu strip and References	See p.5		

Table 1. First-order statistics of the x-ray linear attenuation coefficient (LAC) in TA_LH02_130814, the estimated value of the effective atomic number, Z_{eff} [1] and μ_L/μ_H . Z_{eff} is calculated from the ratio of μ_L/μ_H . Beam hardening compensation has been applied to μ_L using both aluminum (^LZ_{eff}) and water (^{LW}Z_{eff}) beam hardening parameters.

Using x-ray micro computed tomography (MicroCT), we have characterized the linear attenuation coefficients (LAC), μ , of a sample of a dry powder material, tartaric acid (TA). The specimen was prepared at Lawrence Livermore National Laboratory (LLNL), loaded into a 60mL low density polyethylene (LDPE) bottle. After completed packing, the specimen was scanned following the protocol for MicroCT measurements under Test Plan 79 [2].

This particular specimen, TA_LH02_130814, recorded the bulk packing density (mass of sample divided by volume of sample) shown above. Two additional preparations were made and analyzed [3-4]. We used the computer program IMGREC to reconstruct the CT images. The values of the key parameters used in the x-ray data capture and image reconstruction are given in this report. Additional experimental details may be found in the SOP [5] and a separate document [6]. To characterize the statistical distribution of LAC values in each CT image, we first isolated an ~80% region or segment of volume elements (“voxels”) lying completely within the sample, away from the walls of the container. We then calculated the mean value, standard deviation and entropy for (a) the high and low energy image segments and for (b) their digital gradient images². The statistics of the initial image of LAC values are called “first order statistics;” those of the gradient image, “second order statistics.” See Seetho [7] for details of the analysis used to obtain the numbers reported in this document.

¹ LMHU: “LLNL modified Hounsfield units with respect to water.” To obtain the LAC in LMHU for some material at any energy, we multiply by 1000 and divide by the LAC of water at an x-ray energy of 160 kV with aluminum and copper filters.

² A digital gradient image of a given image was obtained by taking the absolute value of the difference between the initial image and that same image offset by one voxel horizontally, parallel to the rows of the x-ray detector array.

Summary of TA_LH02_130814 X-ray Statistics**Report Date:** December 11, 2013**Report Prepared by:** Isaac Seetho
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*Organization***QA:** Isaac Seetho
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*Organization***Material ID(s):** TA_LH02_130814

Source			Collimator	Beam Hardening	Sample Preparation	X-ray Measurement	Linear Attenuation Coefficient (LAC)		
Bias (kV)	Filters		Number of slits	Parameter Source	Date	Date	Statistic	1 st order	2 nd order
	Material	Thickness							
100	Al	1.943 mm	2	H ₂ O	8/9/2013	8/14/2013	Mean Std. Dev. Entropy	1306 370 7.33	257 195 6.52
100	Al	1.943 mm	2	Al	8/9/2013	8/14/2013	Mean Std. Dev. Entropy	1319 420 7.46	288 219 6.64
160	Al Cu	1.943 mm 1.905 mm	2	None	8/9/2013	8/14/2013	Mean Std. Dev. Entropy	888 230 6.86	160 122 6.06
^L Z _{eff}	Based on measured LAC (Al-BHC)							7.96	
^{LW} Z _{eff}	Based on measured LAC (H ₂ O-BHC)							7.29	
μ_L/μ_H	Based on measured LAC (Al-BHC)							1.49	
μ_L/μ_H	Based on measured LAC (H ₂ O-BHC)							1.47	

Table 2. Key statistics [8] for x-ray measurements of Linear Attenuation Coefficient (LAC). ^LZ_{eff} is determined from 100 kV (Al) to 160 kV (AlCu) LAC (μ_L/μ_H) as given in reference [1]. The statistics here are from the 2-slit image data (not the 1-slit open image data).

Comments: _____

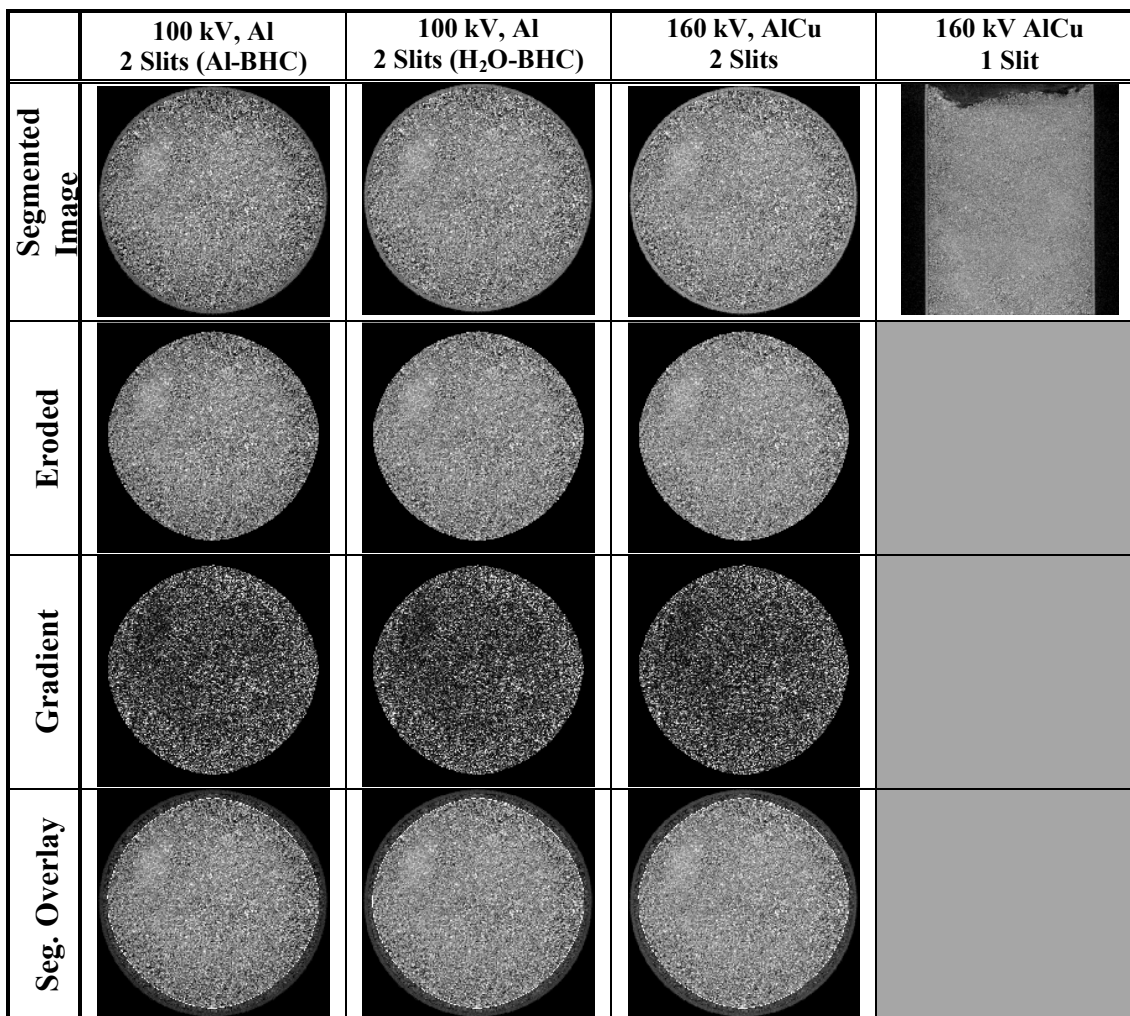


Figure 1. X-ray slice images with $150\mu\text{m} \times 150\mu\text{m} \times 150\mu\text{m}$ voxels. Raw data (top row), segmented images (second row), eroded images (third row) used to calculate first order statistics. Fourth row, difference or gradient image used for second-order statistics. Images not to scale and use different gray scales to obtain maximum contrast. Single slit images (top right) are used for a qualitative visual assessment of homogeneity.

Comments/Observations on Appearance of Sample (texture, color, other):

The specimen displays a generally uniform granulated texture. There are pockets of material that appear to have higher density than other areas.

SUPPLEMENTAL ANALYSIS

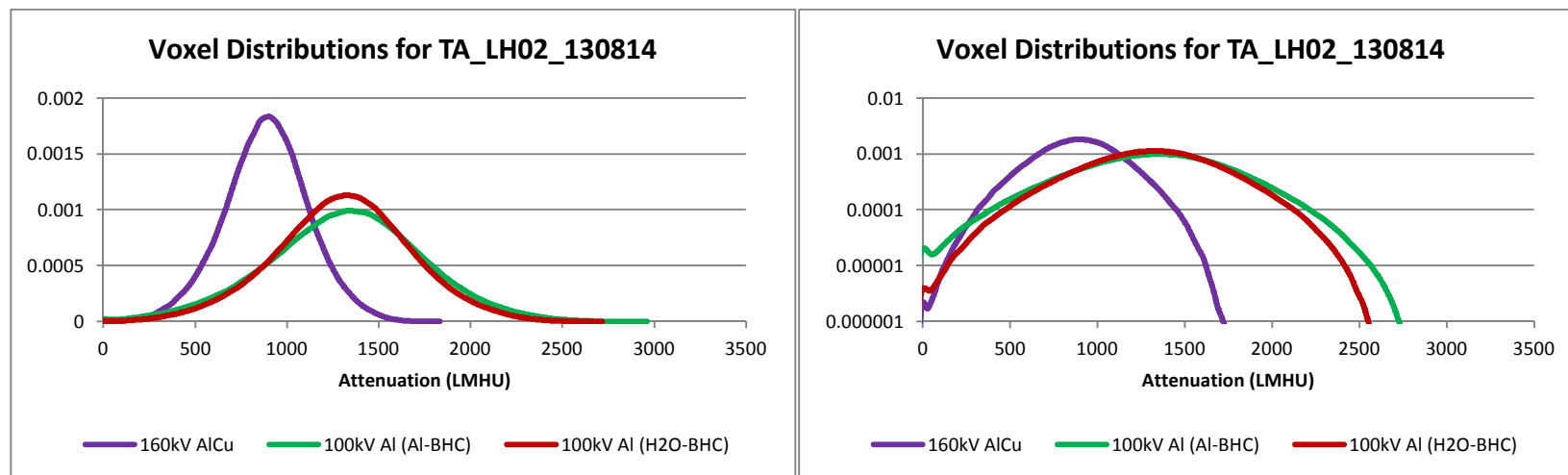


Figure 2. KDE histograms of values of the linear attenuation coefficient (LAC) for TA_LH02_130814 for two x-ray source settings (linear plots – left; semi-log plots – right).

Comments/Observations on Histograms: These histograms are made with a Gaussian Kernel Density Estimator (KDE) [8, 9] using 150- μ m voxel upper-slit CT images.

Reference Specimens

	Parameter	<i>graphite</i>	<i>ethanol</i>	<i>Delrin</i> *	<i>water</i>	<i>Teflon</i> **	<i>aluminum</i> ***
100kV, Al (Al-BHC)	Mean (LMHU)	1733	1033	1804	1405	3038	6989
	Std Dev LMHU)	82	58	80	54	89	133
100kV, Al (H2O-BHC)	Mean (LMHU)	1847	1119	1935	1502	3167	6712
	Std Dev LMHU)	77	59	74	54	65	228
160kV, AlCu	Mean (LMHU)	1396	807	1341	1000	1924	2957
	Std Dev LMHU)	62	47	57	47	60	74

Table 3. Linear attenuation coefficients of six reference materials as measured simultaneously with TA_LH02_130814.

*Acetron® GP copolymer. **Enflo Corp. PTFE. ***T6061 alloy.

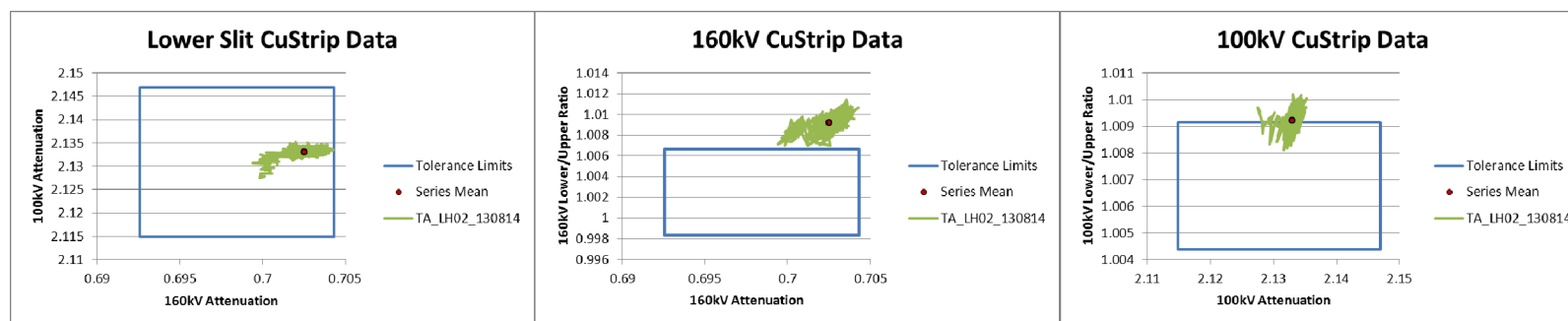


Figure 3. Copper strip ratio values for both 160kV and 100kV are above limits. These tolerance limits were defined using a set of scans spanning from April through May 2013.

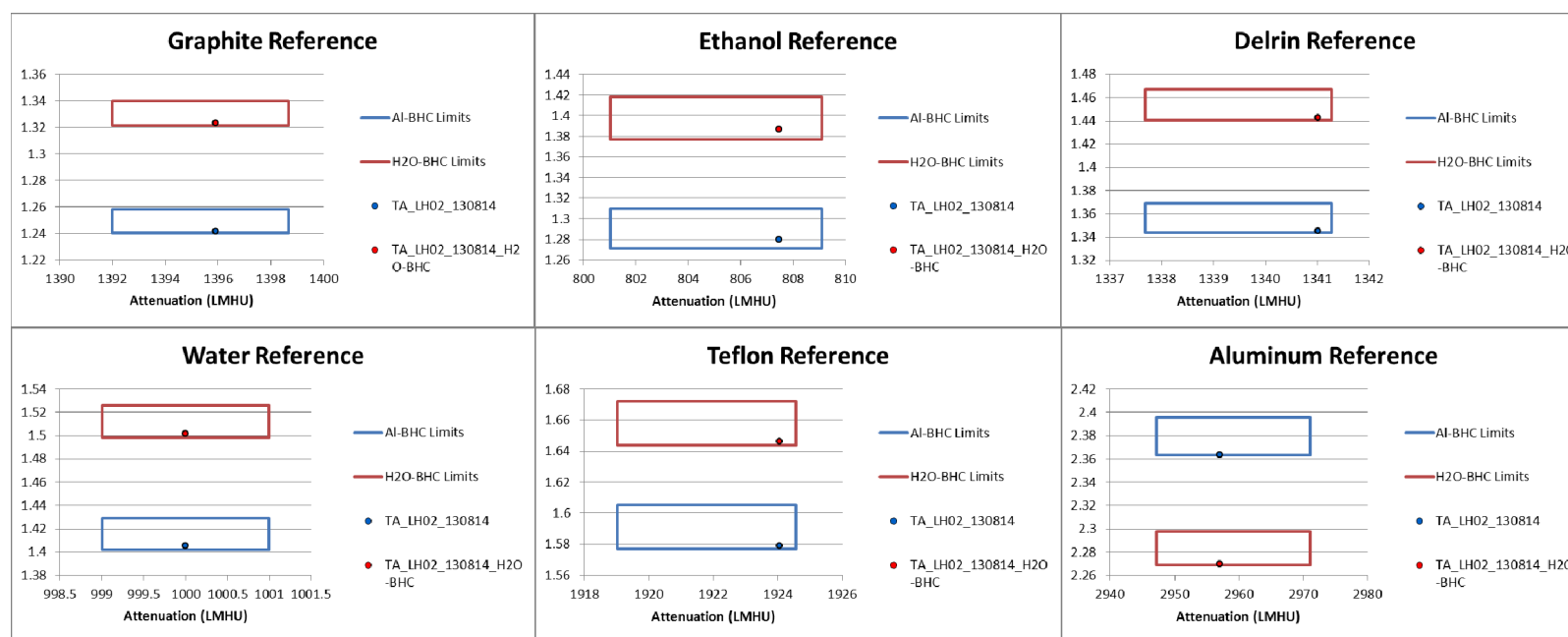


Figure 4. Reference materials are within the defined tolerance limits. These tolerance limits were defined using a set of scans spanning from April through May 2013.

Micro-CT System Configuration

1. Scan Location Site: LLNL HEAF
2. Source: Yxlon D09 450 kV Tube; Mfr. Catalog Number: 9421-172-33503; S/N 21-5204
3. Detector: Thales Flashscan 33 with Lanex Fine Gadolinium Oxysulfate Scintillator Screen; s/n 91106194
4. Rotation control system. Controller: Newport Model ESP7000 SN: 1250
5. Carousel: LLNL 2-tray, 6" Dia.
6. Data capture computer: Dell DHM/J4271

Micro-CT Scan Parameters

1. Scan Geometry:¹ SOD (mm): 1131.0 ODD (mm): 298.7
Number of positions: 400 Angular Range: 200° Angular Increment: 0.5°
2. Number of Frames averaged per Image: 4
3. Integration time per frame: See p 7.

¹ Distances are those recorded in the .sct file for this experiment and are the values used in image reconstruction.

File Storage Locations for X-ray Data

Specimen

Root Data Path:

\\Working\TP79_IMXXXXXX_Microstructure_Studies_V1\LLNL\None\HEAFCAT\None\TA_LH02_130814\Test_Data\{sub directory}\

Specimen ID	Date	Radiographer	Slits	kV	mA	Al Filter (mm)	Cu Filter (mm)	Integration <i>dpix</i> Setting [time/frame (s)]	{sub directory}	File Name
TA_LH02_130814	130814	Morales	2	100	1.1	1.943	0	8 [2.8s]	TA_LH02_130814_100Al	TA_LH02_100Al_ <i>nn</i> .sdt ¹
	130814	Morales	2	160	4.35	1.943	1.905	8 [2.8s]	TA_LH02_130814_160AlCu	TA_LH02_160AlCu_ <i>nn</i> .sdt
	130814	Morales	1	160	4.35	1.943	1.905	8 [2.8s]	TA_LH02_130814_160AlCu1slit	TA_LH02_160AlCu1slit_ <i>nn</i> .sdt

Dark current, mid-range, bright field and I_o

Root Data Path:

\\Working\TP79_IMXXXXXX_Microstructure_Studies_V1\LLNL\None\HEAFCAT\None\TA_LH02_130814\Test_Data\{sub directory}\

Slits	kV	Filter	{sub directory}	Dark Image File Name	Mid-Brightness Image File Name	Max Brightness Image File Name	I_o Image File Name
2	100	Al	TA_LH02_130814_100Al	TA_LH02_100Al _{drk} R.sdt	TA_LH02_100Al _{mid} R.sdt	TA_LH02_100Al _{lit} R.sdt	TA_LH02_100Al _{bak} .sdt
2	160	AlCu	TA_LH02_130814_160AlCu	TA_LH02_160AlCu _{drk} R.sdt	TA_LH02_160AlCu _{mid} R.sdt	TA_LH02_160AlCu _{lit} R.sdt	TA_LH02_160AlCu _{bak} .sdt
1	160	AlCu	TA_LH02_130814_160AlCu1slit	TA_LH02_160AlCu1slit _{drk} R.sdt	TA_LH02_160AlCu1slit _{mid} R.sdt	TA_LH02_160AlCu1slit _{lit} R.sdt	TA_LH02_160AlCu1slit _{bak} .sdt

¹ *nn* - is the CT angular index number (0 through 399) for each individual data file

Reconstruction

Reconstructed by: Kenneth E. Morales

Date: 8/14/2013

Location: LLNL

Computer: Dell Precision 690

Reconstruction Software

Software: IMGREC

Version: 2.8.1.1c11

Beam hardening compensation: Only for 100 kV Al filtered data using Al and H₂O reference materials for compensation.

Script Files

LLNL_script_TA_LH02_100Al.txt

LLNL_script_TA_LH02_160AlCu.txt

LLNL_script_TA_LH02_160AlCu1slit_tw_WDB.txt

LLNL_script_H2OBHC_TA_LH02_100Al.txt

Reconstructed Specimen Files

Root Data Path:

\\Working\TP79_IMXXXXXX_Microstructure_Studies_V1\LLNL\None\HEAFCAT\None\TA_LH02_130814\Reconstruction\
Recon_130814\{sub directory}\

Slits	kV	Filter	{sub directory}	Reconstruction file name
2	100	Al	TA_LH02_130814_100Al	recobj_ <i>nn</i> ¹ .sdt
2	100	Al	H2O_Recon\TA_LH02_130814_100Al	recobj_ <i>nn</i> .sdt
2	160	AlCu	TA_LH02_130814_160AlCu	recobj_ <i>nn</i> .sdt
1	160	AlCu	TA_LH02_130814_160AlCu1slit	recry_ <i>nn</i> .sdt , ry_ <i>nn</i> .sdt

Observations: _____

¹ *nn* - is the index number for each reconstruction file, modified by an offset corresponding to the frame subsection extracted and analyzed.

Analysis

Analysis by: Isaac Seetho

Date: 8/14/2013

Location: LLNL

Computer: Dell Precision T7500

Analysis Software

Software: MATLAB

Version: R2010b

GUI Function/Script Files

micro_ct_gui_1_3.m¹

custrip_gui_split.m

Reference & Specimen Analysis Files

\\Working\TP79_IMXXXXXX_Microstructure_Studies_V1\LLNL\None\HEAFCAT\None\TA_LH02_130814\Analyses\
TA_LH02_130814_analysis_IMS_130814\

Analysis File	TA_LH02_130814_characterization.xlsx
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\\Working\TP79_IMXXXXXX_Microstructure_Studies_V1\LLNL\None\HEAFCAT\None\TA_LH02_130814\Analyses\TA_LH02_130814_H2O-
BHC_analysis_IMS_130814\

Analysis File	TA_LH02_130814_H2O-BHC_characterization_Corrected.xlsx
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Copper Strip Analysis Files

Root Data Path:

\\Working\TP79_IMXXXXXX_Microstructure_Studies_V1\LLNL\None\HEAFCAT\None\TA_LH02_130814\Analyses\
TA_LH02_130814_custrip_IMS_130814\

Aggregate Statistics	Stats_TA_LH02_130814_W80xH7.xls
Mean Value Time Series	Custrip_TA_LH02_130814_W80xH7.xls

¹ Analysis using the MicroCT GUI is done according to the steps outlined in reference [7].

REFERENCES

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5. “Standard Operating Procedure — Industrial Computed Tomography System Data Collection of Home-Made Explosives,” U.S. Department of Homeland Security Science and Technology Directorate, DHS/STD/TSL-xx-xx, July 9, 2009.
6. Jerel A. Smith, Daniel J. Schneberk, Jeffrey S. Kallman, Harry E. Martz, Jr., David Hoey, *Documentation of the LLNL and Tyndall Micro-Computed-Tomography Systems*, Version 091216, Lawrence Livermore National Laboratory, LLNL-TR-421377, December 17, 2009.
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